

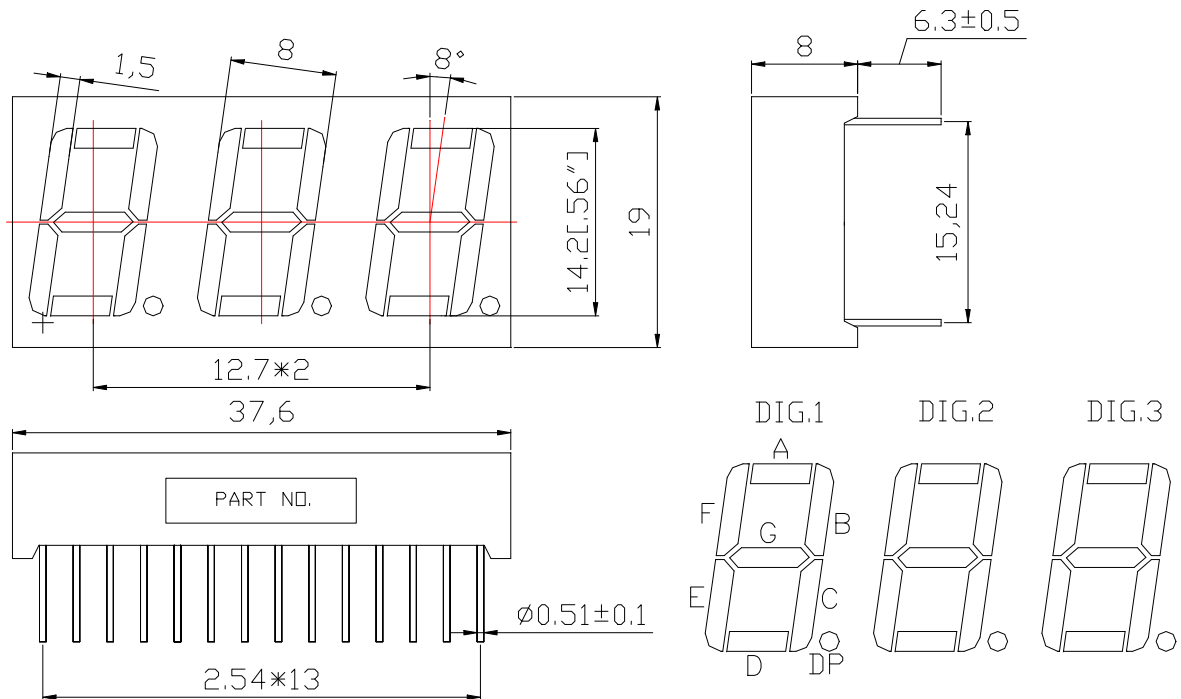
WCN3-0056PG-C21R

SPECIFICATION

WCN			CUSTOMER Confirmed
Prepared by	Checked by	Approved by	
Zhang 2020-7-14	Athena		
REVISION RECORD			

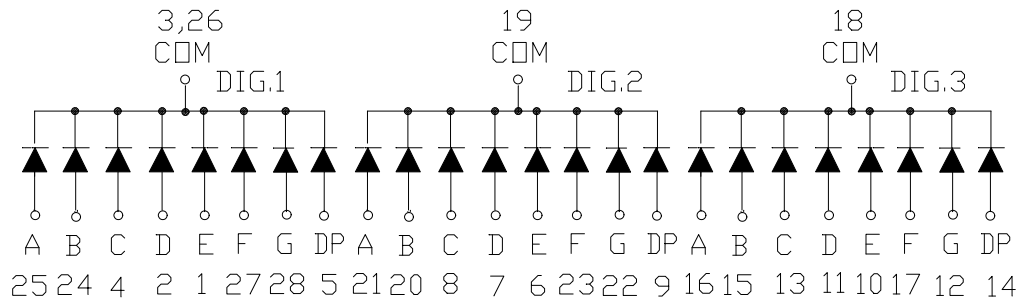
**REVISION: A0**

Outer Dimension:



Note: Unless otherwise stated , The tolerance is ± 0.25 mm.

Circuit Diagram:



Pin Connection:

PIN NO.	CONNECTION	PIN NO.	CONNECTION	PIN NO.	CONNECTION
1	Anode 1E	11	Anode 3D	21	Anode 2A
2	Anode 1D	12	Anode 3G	22	Anode 2G
3	Common Cathode Dig.1	13	Anode 3C	23	Anode 2F
4	Anode 1C	14	Anode DP3	24	Anode 1B
5	Anode DP1	15	Anode 3B	25	Anode 1A
6	Anode 2E	16	Anode 3A	26	Common Cathode Dig.1
7	Anode 2D	17	Anode 3F	27	Anode 1F
8	Anode 2C	18	Common Cathode Dig.3	28	Anode 1G
9	Anode DP2	19	Common Cathode Dig.2	29	
10	Anode 3E	20	Anode 1B	30	

■ **Features:**

- High Reliability
- Color: Pure Green
- Low Power Requirement
- Easy Assembly

■ **Description:**

- Three Digit LED Display
- Digit Height: 14.2mm(0.56")
- Black Face and Milky Segment

■ **Absolute Maximum Rating (Ta=25°C):**

Parameter	Symbol	Condition	Color	Rating	Units
Power Dissipation Per Segment	P _d	—	Pure Green	90	mW
Forward Current Per Segment	I _F	—	Pure Green	25	mA
Peak Forward Current Per Segment	I _{FP}	1/10 Duty 10KHz	Pure Green	100	mA
Reverse Voltage Per Segment	V _R	—	Pure Green	5	V
Operating Temperature Range	T _{opr}	—	—	-35~+85	°C
Storage Temperature Range	T _{stg}	—	—	-35~+85	°C

■ **Electrical/Optical Characteristics Rating(Ta=25°C)**

Item	Symbol	Test conditions	Location	Rating			Units
				Min.	Typ.	Max.	
Forward Voltage	V _F	I _F =20mA	Per Segment	—	3.2	3.60	V
Reverse Current	I _R	V _R =5V	Per Segment	—	—	100	μA
Luminous Intensity	I _V	I _F =10mA	Per Segment	15251	24000	37000	μcd
Peak Emission Wave Length	λ _P	I _F =20mA	Per Segment	—	—	—	nm
	λ _D			520	525	530	
Spectral Line Half Width	Δλ	I _F =20mA	Per Segment	—	20	—	nm
Luminous Intensity Matching Ratio (Segment to Segment)	I _{v-m}	I _F =10mA	—	—	—	1.2:1	

■ **Luminous Intensity Sorting: (Luminous Intensity Tolerance is +/-10%)**

Rank	Symbol	Condition	Min	Max	Unit
S	S	I _F =10mA	15251	18000	μcd
T	T	I _F =10mA	18001	21500	μcd
U	U	I _F =10mA	21501	26000	μcd
V	V	I _F =10mA	26001	31000	μcd
W	W	I _F =10mA	31001	37000	μcd

■ **Soldering Conditions: Soldering Temp. ≤+260°C, Soldering Time. ≤3sec.**
 (at 2mm Distance from The Case of Reflector Edge)

■ LED Displays Reliability Test:

CLASSIFICATION	TEST ITEM	DESCRIPTION AND TEST CONDITION
ENDURANCE TEST	OPERATION LIFE	EVALUATES RESISTANCE OF THE DEVICE WHEN OPERATED AT ELECTRICAL STRESS T _a = UNDER ROOM TEMPERATURE I _F = I _F max
	HIGH TEMPERATURE HIGH HUMIDITY STORAGE	EVALUATES MOISTURE RESISTANCE OF THE DEVICE WHEN STORED FOR A LONG TERM AT HIGH TEMPERATURE AND HUMIDITY T _a = 65±5°C RH=90~95%RH TEST TIME=240± 2Hrs
	HIGH TEMPERATURE STORAGE	EVALUATES DEVICE DURABILITY FOR LONG TERM STORAGE IN HIGH TEMPERATURE T _a = 85±5°C(COB: T _a =65±5°C) TEST TIME=1000Hrs(-24Hrs, +72Hrs)
	LOW TEMPERATURE STORAGE	EVALUATES DEVICE DURABILITY FOR LONG TERM STORAGE IN LOW TEMPERATURE T _a = -35±5°C TEST TIME=1000Hrs(-24Hrs, +72Hrs)
ENVIRONMENTAL TEST	TEMPERATURE CYCLING	EVALUATES RESISTANCE OF DEVICE AT THERMAL STRESSES OR EXPANSION AND CONTRACTION 85°C ~ 25°C ~ -35°C ~ 25°C 30min 5min 30min 5min 10 CYCLES(COB: T _{hot} =65°C, T _{cold} =-25°C)
	THERMAL SHOCK	EVALUATES DEVICE STRUCTURE AND STRUCTURE AND MECHANICAL RESISTANCE WHEN SUDDENLY EXPOSED AT SERVE CHANGES 85±5°C ~ -35±5°C 10min 10min 10 CYCLES(COB: T _{hot} =65°C, T _{cold} =-25°C)
	SOLDERABILITY	EVALUATES SOLDERABILITY ON LEADS OF DEVICE T.SOL=230±5°C DWELL TIME=5±1sec.
	SOLDER RESISTANCE	EVALUATES RESISTANCE TO THERMAL STRESS CAUSED BY SOLDERING T.SOL=260±5°C DWELL TIME=10±1sec.

■ Packing method A :

68 pcs / Red Expandable Polyethylene.

400 pcs / Box(360*175*130mm).

2400 pcs / Catton(550*380*280mm).

■ Package Pattern 2:

13 pcs / IC Tube.

546 pcs / Box(537*175*125mm).

2184 pcs / Catton(550*380*280mm).